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P-Channel 40 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^d	Q _g (Typ.)		
- 40	0.035 at V _{GS} = - 10 V	- 8.2	23 nC		
	0.048 at V _{GS} = - 4.5 V	- 7.2	25110		

FEATURES

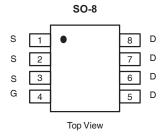
• DT-Trench Power MOSFET

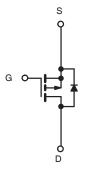
 $\bullet\,$ 100 % R_g and UIS Tested

APPLICATIONS

- Power management
- Load switch
- Battery protection







P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (TA	= 25 °C, unless other	wise noted)			
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-source voltage	V _{DS}	-40	٧		
Gate-source voltage	V _{GS}	± 20	7 v		
	T _C = 25 °C		-8.2		
Continuous drain augment /T 150 °C)	T _C = 70 °C	1 , [-6.8		
Continuous drain current (T _J = 150 °C)	T _A = 25 °C	I _D	-6.7 ^{a, b}		
	T _A = 70 °C	1	-5.6 ^{a, b}		
Pulsed drain current		I _{DM}	-30	A	
Casting and a supplied and a supplied	T _C = 25 °C		-8.2		
Continuous source-drain diode current	T _A = 25 °C	- I _S	-4.1 ^{a, b}	1	
Avalanche current		I _{AS}	-8	1	
Single-pulse avalanche energy	L = 0.1 mH		7.5	mJ	
	T _C = 25 °C		5.3		
Martin and a second second	T _C = 70 °C	1 , [3.7	T ,,,	
Maximum power dissipation	T _A = 25 °C	P _D	2.6 ^{a, b}	W	
	T _A = 70 °C	1	1.8 ^{a, b}		
Operating junction and storage temperature range	T _J , T _{stg}	-55 to +150	°C		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient a, c	t ≤ 10 s	R _{thJA}	35	50	°C/W	
Maximum junction-to-foot	Steady state	R _{thJF}	20	30	C/VV	

Notes

- a. Surface mounted on 1" x 1" FR4 board
- c. Maximum under steady state conditions is 85 °C/W
- d. Based on T_C = 25 $^{\circ}C$



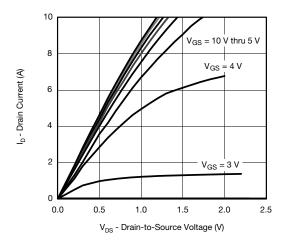
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static			<u> </u>				
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-40	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = -250 μA	-	-42	-	mV/°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = -250 μA	-	4.6	=		
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-1	-	-3	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
7l		V _{DS} = -32 V, V _{GS} = 0 V	-	-	-1	μА	
Zero gate voltage drain current	I _{DSS}	V _{DS} = -32 V, V _{GS} = 0 V, T _J = 55 °C	-	-	-5		
On-state drain current a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	-10	-	-	Α	
	_	$V_{GS} = -10 \text{ V}, I_D = -5 \text{ A}$	-	0.035	0.045		
Drain-source on-state resistance ^a	R _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -4 \text{ A}$	-	0.048	0.065	Ω	
Forward transconductance ^a	9 _{fs}	$V_{DS} = -10 \text{ V}, I_D = -5 \text{ A}$	-	14	-	S	
Dynamic ^b							
Input capacitance	C _{iss}		-	1670	-	pF	
Output capacitance	C _{oss}	$V_{DS} = -32 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	380	-		
Reverse transfer capacitance	C _{rss}		-	105	-		
	Q _g	V _{DS} = -32 V, V _{GS} = -10 V, I _D = -5 A	-	23	-		
Total gate charge			-	10	-		
Gate-source charge	Q _{qs}	$V_{DS} = -32 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -4 \text{ A}$	-	4	-	nC	
Gate-drain charge	Q_{qd}		-	7	-		
Gate resistance	R_q	f = 1 MHz	-	5	-	Ω	
Turn-on delay time	t _{d(on)}		-	10	-		
Rise time	t _r	V_{DD} = -20 V, R_L = 4 Ω $I_D \cong$ -5 A, V_{GEN} = -10 V, R_g = 1 Ω	-	15	-		
Turn-off delay time	t _{d(off)}		-	33	-		
Fall time	t _f		-	9	-		
Turn-on delay time	t _{d(on)}		-	44	-	ns	
Rise time	t _r	$V_{DD} = -20 \text{ V}, R_1 = 4 \Omega$	-	33	-		
Turn-off delay time	t _{d(off)}	$I_D \cong -4 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$	-	58	-		
Fall time	t _f		-	25	-		
Drain-Source Body Diode Characteris	tics						
Continuous source-drain diode current	Is	T _C = 25 °C	-	-	-8.2	Ι.	
Pulse diode forward current	I _{SM}		-	-	-30	- A	
Body diode voltage	V _{SD}	$I_S = -2 \text{ A}, V_{GS} = 0 \text{ V}$	-	-0.7	-1.2	V	
Body diode reverse recovery time	t _{rr}		-	25	50	ns	
Body diode reverse recovery charge	Q _{rr}			17	35	nC	
Reverse recovery fall time	ta	$T_J = 25 ^{\circ}\text{C}$	-	15	-	-	
Reverse recovery rise time	t _b		_	11	_	ns	

Notes

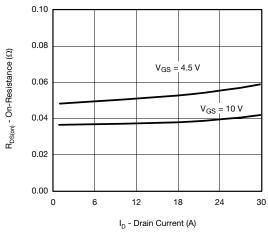
- a. Pulse test; pulse width $\leq 300~\mu\text{s},$ duty cycle $\leq 2\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

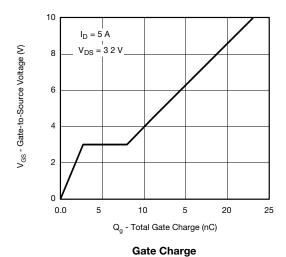


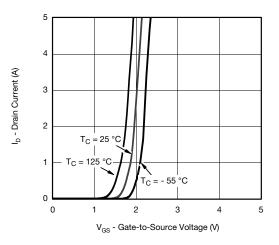


Output Characteristics

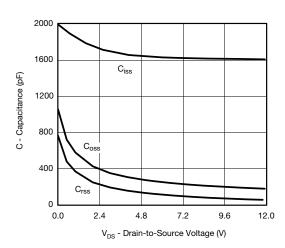


On-Resistance vs. Drain Current

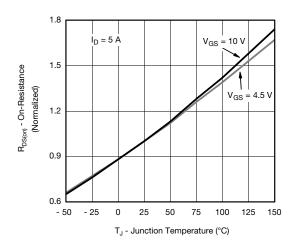




Transfer Characteristics

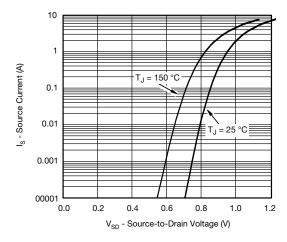


Capacitance

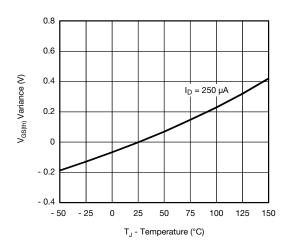


On-Resistance vs. Junction Temperature

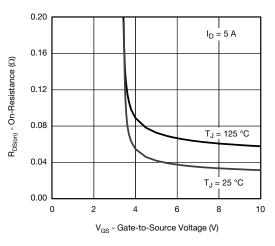




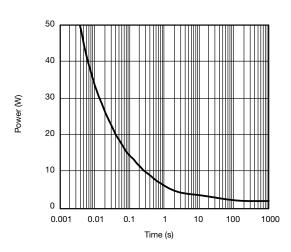
Source-Drain Diode Forward Voltage



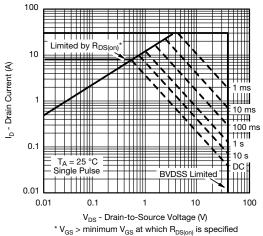
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

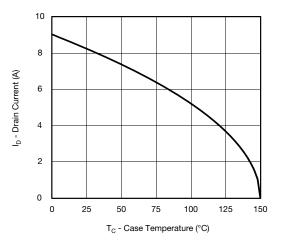


Single Pulse Power, Junction-to-Ambient

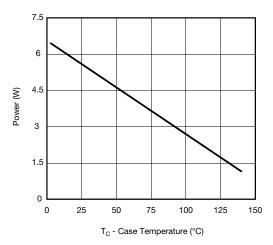


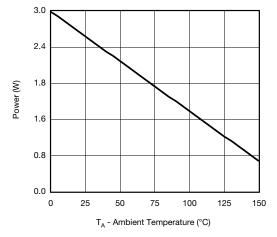
Safe Operating Area





Current Derating a





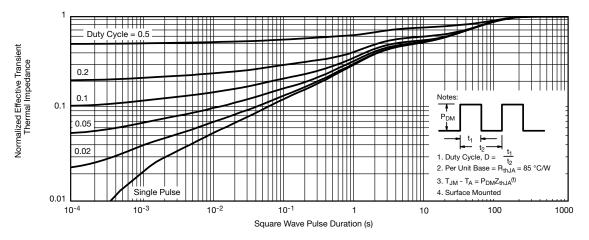
Power, Junction-to-Foot

Power Derating, Junction-to-Ambient

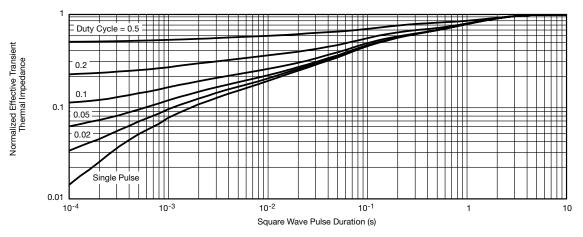
Note

a. The power dissipation P_D is based on T_U max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot





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